

# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Not for submission under 37 CFR 1.99)

Application Number	10/550,209
Filing Date	September 21, 2005
First Named Inventor	Akihiko OKADA
Art Unit	1794
Examiner Name	MARIE R YAMNITZKY
Attorney Docket Number	Q90267

## U.S. PATENTS

Examiner Initials*	Cite No	Patent Number	Kind Code <sup>1</sup>	Issue Date	Name of Patentee or Applicant of cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	1.	5670564		1997-09-23	Gagne et al	
	2.	6361884	B1	2002-03-26	Kreuder et al.	
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Examiner Initials*	Cite No	Publication Number	Kind Code <sup>1</sup>	Publication Date	Name of Patentee or Applicant of cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	1	20010026878	A1	2001-10-04	Woo et al	
	2	20010053842	A1	2001-12-20	Woo et al	
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Examiner Initials*	Cite No	Foreign Document Number <sup>3</sup>	Country Code <sup>2</sup>	Kind Code <sup>4</sup>	Publication Date	Name of Patentee or Applicant of cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>5</sup>
	1	01/49769	WO	A1	2001-07-12	CAMBRIDGE DISPLAY TECHNOLOGY LTD		
	2	2002-293888	JP		2002-10-09	FUJI PHOTO FILM CO LTD		Abstract and machine translation
	3	2000-504774	JP		2000-04-18			Abstract and corresponds to U.S. Patent 6,361,884
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	6	2001-247861	JP		2001-09-14	SUMITOMO CHEMICAL CO		Abstract and corresponds to U.S. Patent Application Publication 2004/0234810
	7	8-81546	JP		1996-03-26	HOECHST AG		Abstract and corresponds to U.S. Patent 5,728,480

## NON-PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.	T <sup>5</sup>
	1	S. TRIMPIN et al, "Characterization of an Insoluble Poly(9,9-diphenyl-2,7-Fluorene) by Solvent-Free Sample Preparation for MALDI-TOF Mass Spectrometry", Analytical Chemistry, Vol. 74, No. 15, August 1, 2002, 3777-3782	
	2	H. CHEN et al., "End-Group Analysis of Blue Light-Emitting Polymers Using Matrix-Assisted Laser Desorption/Ionization Time-of-Flight Mass Spectrometry", Analytical Chemistry, Vol. 74, No. 24, December 15, 2002, 6252-6258	

## EXAMINER SIGNATURE

Examiner Signature		Date Considered	
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